

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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Examiner		Art Unit	Thong Q Nguyen	
		2872	Page 1 of 1	

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	B	US-6,692,647	02-2004	Moshrefzadeh et al	216/24
	C	US-			
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	F	US-			
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	I	US-			
	J	US-			
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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